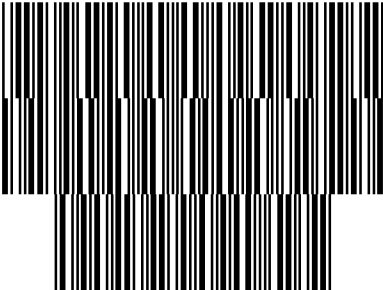


<p style="text-align: center;"><b>Search Notes</b></p> 	<p><b>Application/Control No.</b></p> <p>105662021163346312218260</p>	<p><b>Applicant(s)/Patent Under Reexamination</b></p> <p>TANAKA ET AL.TAMAGAWA ET AL.SCHWENDIMANN ET AL.</p>
	<p><b>Examiner</b></p> <p>Bruce H HessBruce H HessBruce H Hess</p>	<p><b>Art Unit</b></p> <p>179417941794</p>

SEARCHED			
Class	Subclass	Date	Examiner
See WEST search		12/31/08	bhh
See WEST search		05/26/09	BHH
See WEST searchSee WEST search		01/11/0909/21/2009	BHHBHH
See WEST searchSee WEST search		02/15/201010/28/08	BHH/BHH/
See WEST search		05/18/09	BHH
See WEST search		10/15/09	BHH
See WEST search		02/15/2010	BHH

SEARCH NOTES		
Search Notes	Date	Examiner
See vWEST searchSee WEST searchSee WEST search	01/11/0902/15/201010/28/08	BHHBHH/BHH/
See WEST search	02/15/2010	BHH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
See WEST searchSee WEST searchSee WEST search		01/11/0902/15/2 01002/15/2010	BHHBHHBHH

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